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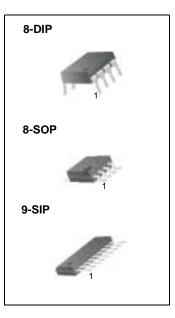
KA4558 Dual Operational Amplifier

Features

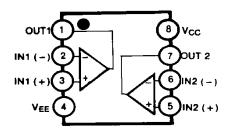
- No frequency compensation required.
- No latch up.
- Large common mode and differential voltage range.
- Parameter tracking over temperature range.
- Gain and phase match between amplifiers.
- Internally frequency compensated.
- Low noise input transistors.

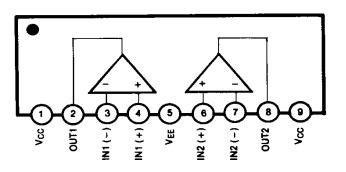
Descriptions

The KA4558 is a monolithic integrated circuit designed for dual operational amplifier.



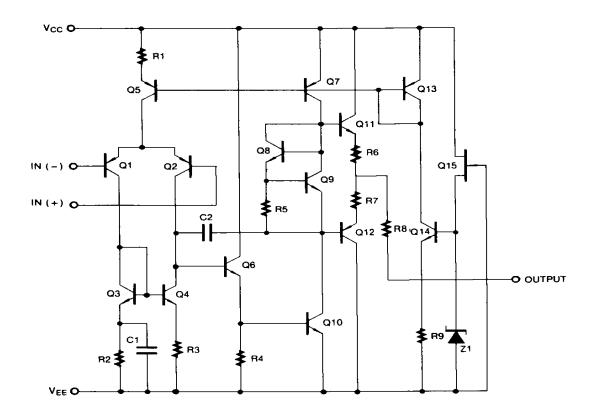
Internal Block Diagram





Schematic Diagram

(One Section Only)



Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Supply Voltage	Vcc	±22	V
Differential Input Voltage	VI(DIFF)	30	V
Input Voltage	VI	±15	V
Power Dissipation	PD	400	mW
Operating Temperature Range KA4558 KA4558I	Topr	0 ~ 70 -40 ~ 85	°C
Storage Temperature Range	TSTG	-65 ~ 150	°C

Electrical Characteristics

(VCC = 15V, VEE = - 15V , TA = 25 °C unless otherwise specified)

Devemeter	Cumhal	Conditions		KA4558/KA4558I			11
Parameter	Symbol			Min	Тур	Max	Unit
Input Offset Voltage	N/IC	Rs≤10KΩ		-	2	6	mV
	VIO		Note 1	-	-	7.5	IIIV
Input Offset Current				-	5	200	
	lio		TA=TA(MAX)	-	-	300	nA
			TA =TA(MIN)	-	-	300	
Input Bias Current			T _A =T _A (MAX)		30	500	nA
	IBIAS				-	800	
			TA =TA(MIN)	-	-	800	
Large Signal		VO(P-P)= ±1	0V,RL≤2KΩ	20	200	-	V/mV
Voltage Gain	0,		Note 1	-	-	-	V/IIIV
Common Mode Input Voltage Range	VI(R)				±13	-	V
	VI(R)		Note 1	-	-	-	v
Common Mode Rejection Ratio	CMRR	Rs≤10KΩ		70	90	-	- dB
	CIMICIC		Note 1	-	-	-	
Supply Voltage Rejection Ratio	PSRR	Rs≤10KΩ		76	90	-	dB
	1 OKK		Note 1	76	90	-	чЪ
Output Voltage Swing	VO(P-P)	RL≥10KΩ	- Note1	±12	±14	-	V
	VO(P-P)	RL≥2KΩ	Noter	±10	±13	-	
Supply Current (Both Amplifiers)				-	3.5	5.8	mA
	ICC		TA =TA(MAX)	1	-	5.0	
			TA =TA(MIN)	-	-	6.7	
Power Consumption (Both Amplifiers)		TA =TA(MAX)		1	70	170	mW
	PC			-	-	150	
			$T_a = T_A(MIN)$	-	-	200	
Slew Rate (Note2)	SR	VI =10V, RL≥2KΩ CI≤100pF		1.2	-	-	V/µs
Rise Time (Note2)	TR	VI =20mV, RL≥2KΩ CI≤100pF		-	0.3	-	μs
Overshoot (Note2)	OS	VI =20mV, RL≥2KΩ CI≤100pF		-	15	-	%

Note :

 $1. \text{ KA4558}: \text{T}_{A}(\text{MIN}) \leq \text{T}_{A} \leq \text{T}_{A}(\text{MAX}) = 0 \leq \text{T}_{A} \leq 70 \ ^{\circ}\text{C} \ , \ \text{KA4558I}: \text{T}_{A}(\text{MIN}) \leq \text{T}_{A} \leq \text{T}_{A}(\text{MAX}) = -40 \leq \text{T}_{A} \leq +85 \ ^{\circ}\text{C}$

2. Guaranteed by design.



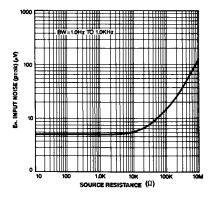


Figure 1. Burst Noise vs Source Resistance

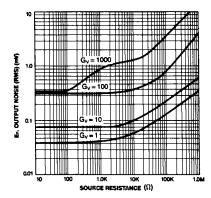


Figure 3. Output Noise vs Source Resistance

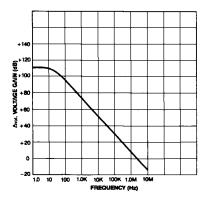


Figure 5. Open Loop Frequency Response

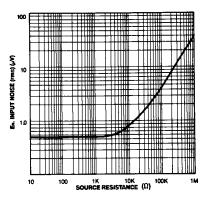


Figure 2. RMS Noise vs Source Resistance

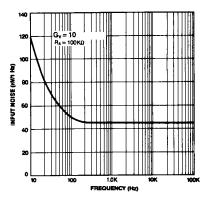


Figure 4. Spectral Noise Density

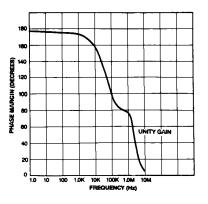


Figure 6. Phase Margin vs Frequency

Typical Performance Characteristics (continued)

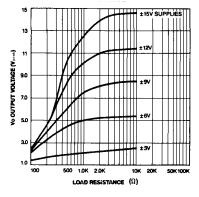


Figure 7. Positive Output Voltage Swing vs Load Resistance

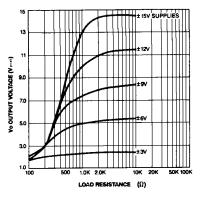


Figure 8. Negative Output Voltage Swing vs Load Resistance

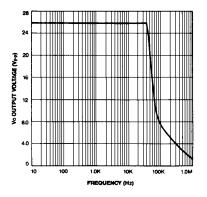
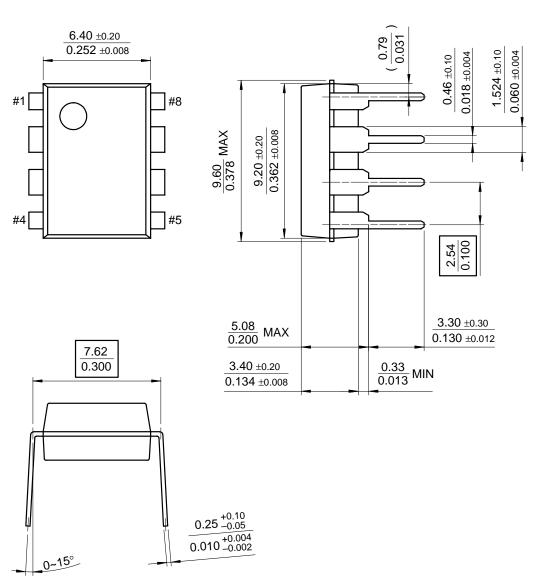


Figure 9. Power Bandwidth (Large Signal Output Swing vs Frequency)

Mechanical Dimensions

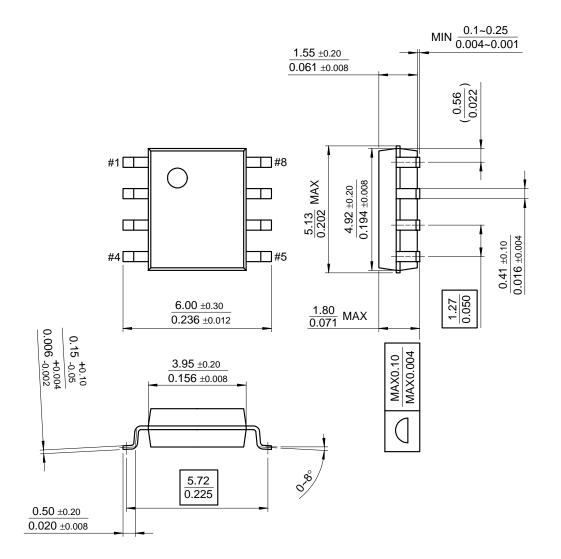
Package



8-DIP

Mechanical Dimensions (Continued)

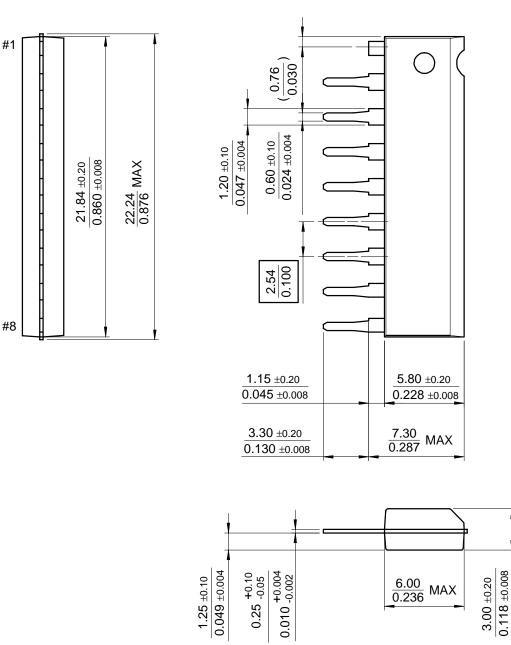
Package



8-SOP

Mechanical Dimensions (Continued)

Package



9-SIP

Ordering Information

Product Number	Package	Operating Temperature		
KA4558	8-DIP			
KA4558D	8-SOP	0 ~ + 70°C		
KA4558S	9-SIP			
KA4558I	8-DIP	-40 ~ + 85°C		

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- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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